Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/816,855	OKANO, AKIHIRO	
Examiner	Art Unit	
Aaron M. Richer	2628	

	SEAR	CHED	
Class	Subclass	Date	Examiner
345	617	6/7/2006	AMR
Above	Updated	9/7/2006	AMR
348	173	9/7/2006	AMR

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Updated previous examiner's seach - EAST (USPGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB) - see search history printout	6/7/2006	AMR
Updated	9/7/2006	AMR